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# 捷多邦,专业PCB打样工厂,24小**岛NS4F**遼2, SN74F32 QUADRUPLE 2-INPUT POSITIVE-OR GATES

SDFS044B - MARCH 1987 - REVISED MAY 1999

Package Options Include Plastic SN54F32 ... J PACKAGE SN74F32 ... D OR N PACKAGE Small-Outline (D) Packages, Ceramic Chip (TOP VIEW) Carriers (FK), and Standard Plastic (N) and Ceramic (J) DIPs 14 VCC 1A 1B 13 4B 2 description 1Y 12 4A 3 2A [ 4Y These devices contain four independent 2-input 4 11 OR gates. They perform the Boolean functions 2B | 🛛 3B 10 5 Y = A + B or  $Y = \overline{A} \cdot \overline{B}$  in positive logic. 2Y 6 9 3A 3Y GND 8 П The SN54F32 is characterized for operation over the full military temperature range of -55°C to 125°C. The SN74F32 is characterized for SN54F32 ... FK PACKAGE operation from 0°C to 70°C. (TOP VIEW) VCC 4B ₹Ÿ **FUNCTION TABLE** (each gate) 3 2 1 20 19 INPUTS OUTPUT 18 4A 1Y Y Α В NC 5 17 NC Н Х Н 2A 6 16 4Y Х Н Н NC Π7 15 NC L L Т 2B Π8 14 3B 10 11 12 13 9 GND 3Y NC 3A 2 NC - No internal connection WWW.DZSC.COM logic symbol<sup>†</sup> 1 3 **1**A ≥1 1Y 2 1B 4 2A 6 2Y 5 2B 9 3A 8 10 3Y 3B 12 4Δ 11 13 4B <sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, J, and N packages. logic diagram, each gate (positive logic) B Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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# SN54F32, SN74F32 QUADRUPLE 2-INPUT POSITIVE-OR GATES

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### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub> Input voltage range, V <sub>I</sub> (see Note 1)	
Input current range	
Voltage range applied to any output in the high state	
Current into any output in the low state	
Package thermal impedance, $\theta_{JA}$ (see Note 2): D package	
Storage temperature range, T <sub>stg</sub>	

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input voltage ratings may be exceeded provided the input current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.

### recommended operating conditions (see Note 3)

		SN54F32			SN74F32			UNIT	
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V	
VIH	High-level input voltage	2			2			V	
VIL	Low-level input voltage			0.8			0.8	V	
Iк	Input clamp current			-18			-18	mA	
IOH	High-level output current			-1			-1	mA	
IOL	Low-level output current			20			20	mA	
Τ <sub>Α</sub>	Operating free-air temperature	-55		125	0		70	°C	

NOTE 3: All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS			SN54F32			SN74F32			
PARAMETER			MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT	
VIK	V <sub>CC</sub> = 4.5 V,	I <sub>I</sub> = -18 mA			-1.2			-1.2	V	
Veu	V <sub>CC</sub> = 4.5 V,	I <sub>OH</sub> = -1 mA	2.5	3.4		2.5	3.4		V	
∨он	V <sub>CC</sub> = 4.75 V,	I <sub>OH</sub> = -1 mA				2.7			v	
VOL	V <sub>CC</sub> = 4.5 V,	I <sub>OL</sub> = 20 mA		0.3	0.5		0.3	0.5	V	
lį	V <sub>CC</sub> = 5.5 V,	$V_{I} = 7 V$			0.1			0.1	mA	
Ιн	V <sub>CC</sub> = 5.5 V,	VI = 2.7 V			20			20	μA	
۱ <sub>IL</sub>	V <sub>CC</sub> = 5.5 V,	V <sub>I</sub> = 0.5 V			-0.6			-0.6	mA	
IOS§	V <sub>CC</sub> = 5.5 V,	$V_{O} = 0$	-60		-150	-60		-150	mA	
ICCH	V <sub>CC</sub> = 5.5 V			6.1	9.2		6.1	9.2	mA	
ICCL	V <sub>CC</sub> = 5.5 V,	$V_{I} = 0$		10.3	15.5		10.3	15.5	mA	

<sup>‡</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

§ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

 $\P$  I<sub>CCH</sub> is measured with one input per gate at 4.5 V and all others grounded.



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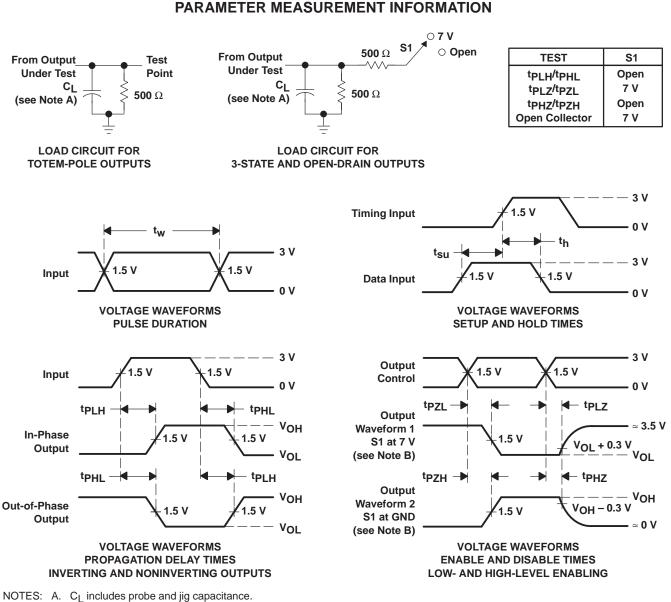
# switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 5 V, T <sub>A</sub> = 25°C			SN54F32		SN74F32		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	
<sup>t</sup> PLH	A or B		2.2	3.8	5.6	2.2	7.5	2.2	6.6	-
<sup>t</sup> PHL			2.2	3.6	5.3	1.7	7.5	2.2	6.3	ns



### SN54F32, SN74F32 QUADRUPLE 2-INPUT POSITIVE-OR GATES

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- - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>r</sub>  $\leq$  2.5 ns, t<sub>f</sub>  $\leq$  2.5 ns, duty cycle = 50%.
  - D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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